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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Obsolete
Core Processor	870/C
Core Size	8-Bit
Speed	16MHz
Connectivity	I <sup>2</sup> C, SIO, UART/USART
Peripherals	PWM, WDT
Number of I/O	56
Program Memory Size	60KB (60K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 16x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	64-BQFP
Supplier Device Package	64-QFP (14x14)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/toshiba-semiconductor-and-storage/tmp86fs49fg">https://www.e-xfl.com/product-detail/toshiba-semiconductor-and-storage/tmp86fs49fg</a>

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## 12. 10-bit successive approximation type AD converter

Analog inputs: 16ch

## 13. Key On Wake Up : 4ch

## 14. Clock operation

Single clock mode

Dual clock mode

## 15. Low power consumption operation

STOP mode: Oscillation stops. (Battery/Capacitor back-up.)

SLOW1 mode: Low power consumption operation using low-frequency clock.(High-frequency clock stop.)

SLOW2 mode: Low power consumption operation using low-frequency clock.(High-frequency clock oscillate.)

IDLE0 mode: CPU stops, and only the Time-Based-Timer(TBT) on peripherals operate using high frequency clock. Release by falling edge of the source clock which is set by TBTCCR<TBTCK>.

IDLE1 mode: CPU stops and peripherals operate using high frequency clock. Release by interrupts(CPU restarts).

IDLE2 mode: CPU stops and peripherals operate using high and low frequency clock. Release by interrupts. (CPU restarts).

SLEEP0 mode: CPU stops, and only the Time-Based-Timer(TBT) on peripherals operate using low frequency clock.Release by falling edge of the source clock which is set by TBTCCR<TBTCK>.

SLEEP1 mode: CPU stops, and peripherals operate using low frequency clock. Release by interrupt.(CPU restarts).

SLEEP2 mode: CPU stops and peripherals operate using high and low frequency clock. Release by interrupt.

## 16. Wide operation voltage:

4.5 V~5.5 V at 16.0MHz /32.768 kHz

3.0 V~3.6 V at 8 MHz /32.768 kHz

## 1.4 Pin Names and Functions

Table 1-1 Pin Names and Functions ( 1/3 )

Pin Name	Pin Number	Input/Output	Functions
P07 INT2	17	IO I	PORT07 External interrupt 2 input
P06 SCK1	16	IO IO	PORT06 Serial clock input/output 1
P05 SO1	15	IO O	PORT05 Serial data output 1
P04 SI1	14	IO I	PORT04 Serial data input 1
P03 INT1	13	IO I	PORT03 External interrupt 1 input
P02 TxD1	12	IO O	PORT02 UART data output 1
P01 RxD1 BOOT	11	IO I I	PORT01 UART data input 1 Serial PROM mode control input
P00 INT0	10	IO I	PORT00 External interrupt 0 input
P17 TC6 PDO6/PWM6/PPG6	51	IO I O	PORT17 Timer counter 6 input PDO6/PWM6/PPG6 output
P16 TC5 PDO5/PWM5	50	IO I O	PORT16 Timer counter 5 input PDO5/PWM5 output
P15 TC2 INT3	49	IO I I	PORT15 Timer counter 2 input External interrupt 3 input
P14 TC4 PDO4/PWM4/PPG4	48	IO I O	PORT14 Timer counter 4 input PDO4/PWM4/PPG4 output
P13 TC3 PDO3/PWM3	47	IO I O	PORT13 Timer counter 3 input PDO3/PWM3 output
P12 PPG	46	IO I	PORT12 PPG Output
P11 DVO	45	IO O	PORT11 Divider output
P10 TC1	44	IO I	PORT10 Timer counter 1 input
P22 XTOUT	7	IO O	PORT22 Resonator connecting pins(32.768kHz) for inputting external clock
P21 XTIN	6	IO I	PORT21 Resonator connecting pins(32.768kHz) for inputting external clock
P20 INT5 STOP	9	IO I I	PORT20 External interrupt 5 input STOP mode release signal input

Table 1-1 Pin Names and Functions ( 3/3 )

Pin Name	Pin Number	Input/Output	Functions
P61 AIN01	21	IO I	PORT61 AD converter analog input 1
P60 AIN00	20	IO I	PORT60 AD converter analog input 0
P77 AIN17	35	IO I	PORT77 AD converter analog input 17
P76 AIN16	34	IO I	PORT76 AD converter analog input 16
P75 AIN15	33	IO I	PORT75 AD converter analog input 15
P74 AIN14	32	IO I	PORT74 AD converter analog input 14
P73 AIN13	31	IO I	PORT73 AD converter analog input 13
P72 AIN12	30	IO I	PORT72 AD converter analog input 12
P71 AIN11	29	IO I	PORT71 AD converter analog input 11
P70 AIN10	28	IO I	PORT70 AD converter analog input 10
XIN	2	I	Resonator connecting pins for high-frequency clock
XOUT	3	O	Resonator connecting pins for high-frequency clock
<u>RESET</u>	8	I	Reset signal input
TEST	4	I	Test pin for out-going test and the Serial PROM mode control pin. Usually fix to low level. Fix to high level when the Serial PROM mode starts.
VAREF	18	I	Analog reference voltage input (High)
AVDD	19	I	AD circuit power supply
VDD	5	I	+5V
VSS	1	I	0(GND)

## 2. Operational Description

### 2.1 CPU Core Functions

The CPU core consists of a CPU, a system clock controller, and an interrupt controller.

This section provides a description of the CPU core, the program memory, the data memory, and the reset circuit.

#### 2.1.1 Memory Address Map

The TMP86FS49FG memory consists of 4 blocks: FLASH, RAM, DBR (Data buffer register) and SFR (Special function register). They are all mapped in 64-Kbyte address space. Figure 2-1 shows the TMP86FS49FG memory address map. The general-purpose registers are not assigned to the RAM address space.

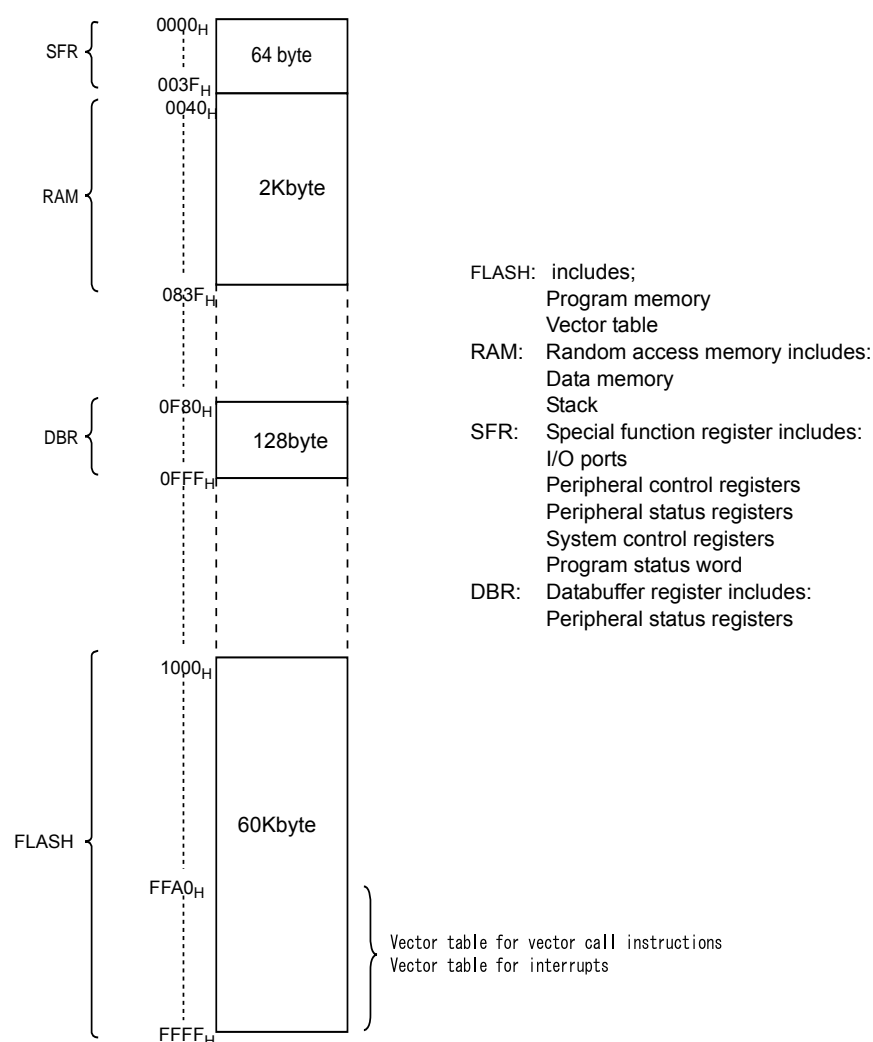


Figure 2-1 Memory Address Map

### 2.2.1 Clock Generator

The clock generator generates the basic clock which provides the system clocks supplied to the CPU core and peripheral hardware. It contains two oscillation circuits: One for the high-frequency clock and one for the low-frequency clock. Power consumption can be reduced by switching of the standby controller to low-power operation based on the low-frequency clock.

The high-frequency ( $f_c$ ) clocks and low-frequency ( $f_s$ ) clock can easily be obtained by connecting a resonator between the XIN/XOUT and XTIN/XTOUT pins respectively. Clock input from an external oscillator is also possible. In this case, external clock is applied to XIN/XTIN pin with XOUT/XTOUT pin not connected.

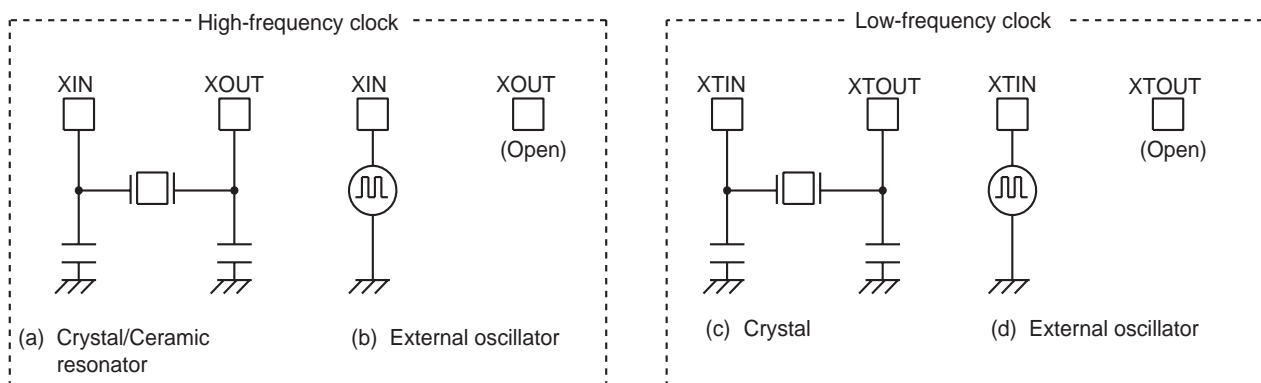


Figure 2-3 Examples of Resonator Connection

Note: The function to monitor the basic clock directly at external is not provided for hardware, however, with disabling all interrupts and watchdog timers, the oscillation frequency can be adjusted by monitoring the pulse which the fixed frequency is outputted to the port by the program.  
The system to require the adjustment of the oscillation frequency should create the program for the adjustment in advance.

### 2.2.2 Timing Generator

The timing generator generates the various system clocks supplied to the CPU core and peripheral hardware from the basic clock ( $f_c$  or  $f_s$ ). The timing generator provides the following functions.

1. Generation of main system clock
2. Generation of divider output ( $\overline{DVO}$ ) pulses
3. Generation of source clocks for time base timer
4. Generation of source clocks for watchdog timer
5. Generation of internal source clocks for timer/counters
6. Generation of warm-up clocks for releasing STOP mode

#### 2.2.2.1 Configuration of timing generator

The timing generator consists of a 2-stage prescaler, a 21-stage divider, a main system clock generator, and machine cycle counters.

An input clock to the 7th stage of the divider depends on the operating mode, DV7CK (Bit4 in TBTCR), that is shown in Figure 1-5. As reset and STOP mode started/canceled, the prescaler and the divider are cleared to "0".

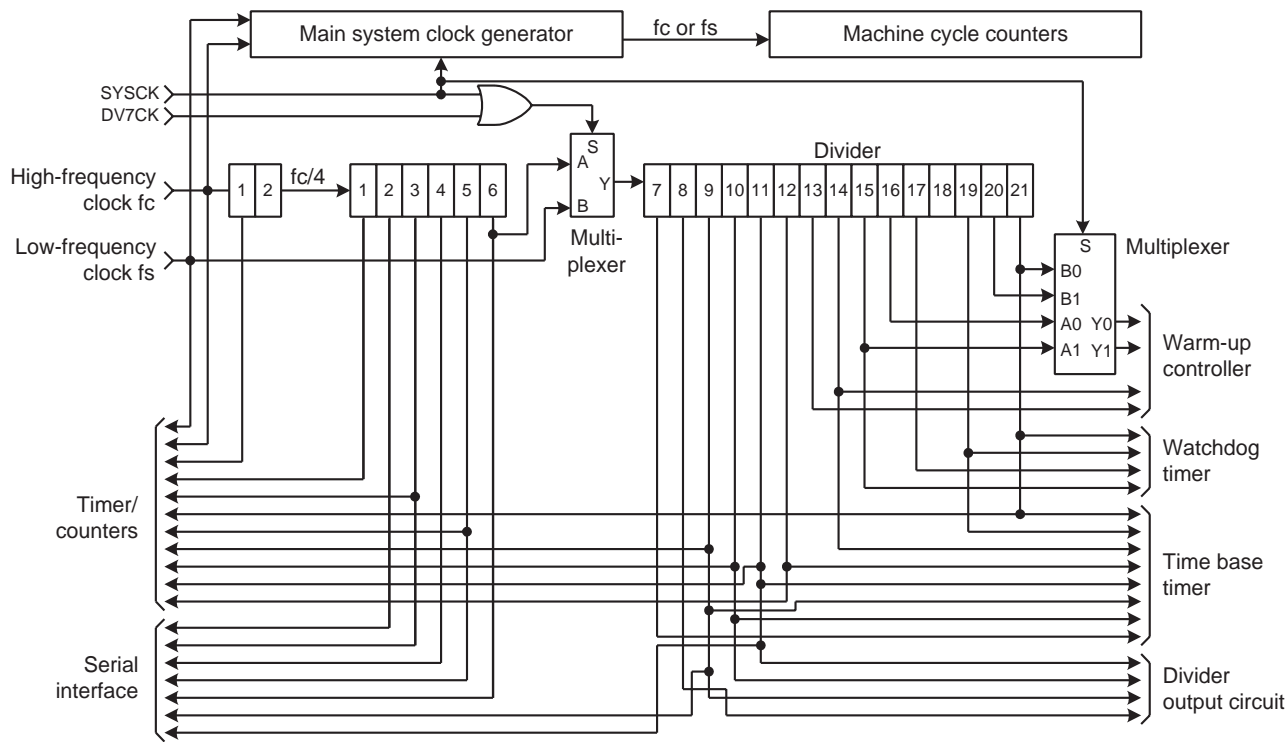


Figure 2-4 Configuration of Timing Generator

Timing Generator Control Register

TBTCR (0036H)	7	6	5	4	3	2	1	0	
	(DVOEN)	(DVOCK)	DV7CK	(TBTEN)	(TBTCK)				(Initial value: 0000 0000)
DV7CK	Selection of input to the 7th stage of the divider				0: $fc/2^8$ [Hz] 1: fs				R/W

- Note 1: In single clock mode, do not set DV7CK to “1”.
- Note 2: Do not set “1” on DV7CK while the low-frequency clock is not operated stably.
- Note 3: fc: High-frequency clock [Hz], fs: Low-frequency clock [Hz], \*: Don't care
- Note 4: In SLOW1/2 and SLEEP1/2 modes, the DV7CK setting is ineffective, and fs is input to the 7th stage of the divider.
- Note 5: When STOP mode is entered from NORMAL1/2 mode, the DV7CK setting is ineffective during the warm-up period after release of STOP mode, and the 6th stage of the divider is input to the 7th stage during this period.

2.2.2.2 Machine cycle

Instruction execution and peripheral hardware operation are synchronized with the main system clock.

The minimum instruction execution unit is called an “machine cycle”. There are a total of 10 different types of instructions for the TLCS-870/C Series: Ranging from 1-cycle instructions which require one machine cycle for execution to 10-cycle instructions which require 10 machine cycles for execution. A machine cycle consists of 4 states (S0 to S3), and each state consists of one main system clock.



When the  $\overline{\text{STOP}}$  pin input is high, executing an instruction which starts STOP mode will not place in STOP mode but instead will immediately start the release sequence (Warm up). Thus, to start STOP mode in the level-sensitive release mode, it is necessary for the program to first confirm that the  $\overline{\text{STOP}}$  pin input is low. The following two methods can be used for confirmation.

- 1. Testing a port P20.
- 2. Using an external interrupt input  $\overline{\text{INT5}}$  ( $\overline{\text{INT5}}$  is a falling edge-sensitive input).

Example 1 :Starting STOP mode from NORMAL mode by testing a port P20.

```
LD      (SYSCR1), 01010000B    ; Sets up the level-sensitive release mode
SSTOPH: TEST  (P2PRD). 0        ; Wait until the  $\overline{\text{STOP}}$  pin input goes low level
JRS     F, SSTOPH
DI      ; IMF ← 0
SET     (SYSCR1). 7            ; Starts STOP mode
```

Example 2 :Starting STOP mode from NORMAL mode with an INT5 interrupt.

```
PINT5:  TEST  (P2PRD). 0        ; To reject noise, STOP mode does not start if
JRS     F, SINT5                port P20 is at high
LD      (SYSCR1), 01010000B    ; Sets up the level-sensitive release mode.
DI      ; IMF ← 0
SET     (SYSCR1). 7            ; Starts STOP mode
SINT5:  RETI
```

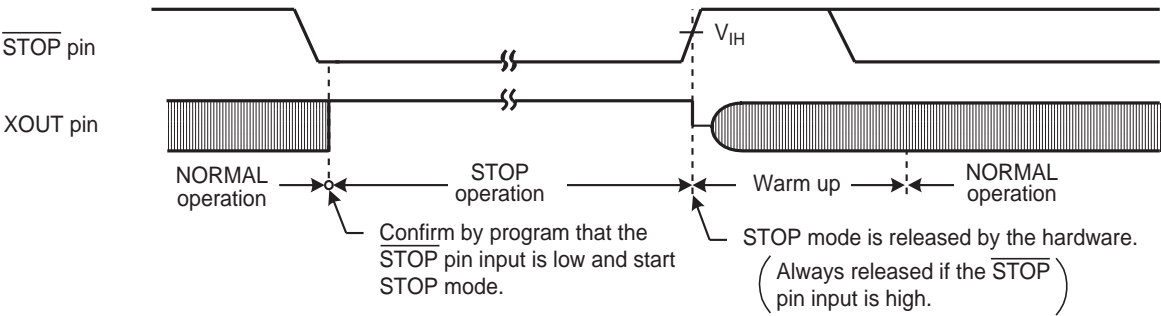


Figure 2-7 Level-sensitive Release Mode

Note 1: In this case of changing to the level-sensitive mode from the edge-sensitive mode, the release mode is not switched until a rising edge of the  $\overline{\text{STOP}}$  pin input is detected.

(2) Edge-sensitive release mode (RELM = “0”)

In this mode, STOP mode is released by a rising edge of the  $\overline{\text{STOP}}$  pin input. This is used in applications where a relatively short program is executed repeatedly at periodic intervals. This periodic signal (for example, a clock from a low-power consumption oscillator) is input to the  $\overline{\text{STOP}}$  pin. In the edge-sensitive release mode, STOP mode is started even when the  $\overline{\text{STOP}}$  pin input is high level.

Example :Starting STOP mode from NORMAL mode

```
DI      ; IMF ← 0
LD      (SYSCR1), 10010000B    ; Starts after specified to the edge-sensitive release mode
```

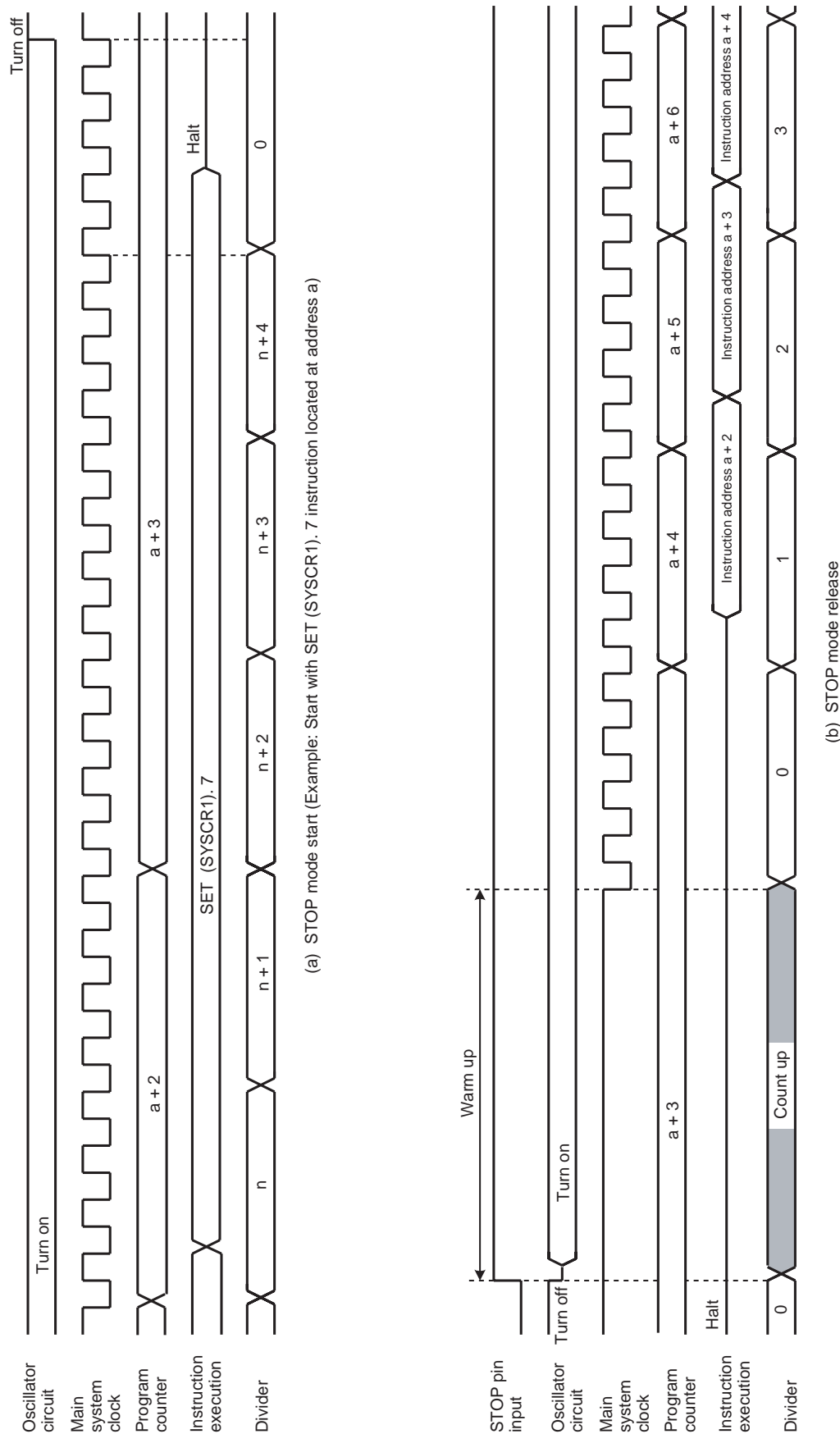


Figure 2-9 STOP Mode Start/Release

### 2.2.4.2 IDLE1/2 mode and SLEEP1/2 mode

IDLE1/2 and SLEEP1/2 modes are controlled by the system control register 2 (SYSCR2) and maskable interrupts. The following status is maintained during these modes.

1. Operation of the CPU and watchdog timer (WDT) is halted. On-chip peripherals continue to operate.
2. The data memory, CPU registers, program status word and port output latches are all held in the status in effect before these modes were entered.
3. The program counter holds the address 2 ahead of the instruction which starts these modes.

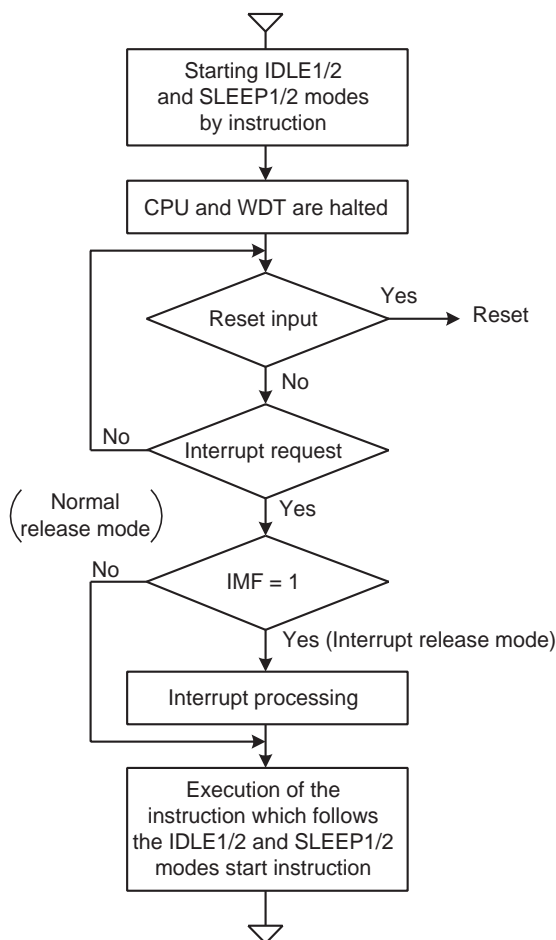


Figure 2-10 IDLE1/2 and SLEEP1/2 Modes

#### (1) Start the IDLE1/2 and SLEEP1/2 modes

When IDLE1/2 and SLEEP1/2 modes start, set SYSCR2<IDLE> to "1". After IMF is set to "0", set the individual interrupt enable flag (EF) which releases IDLE1/2 and SLEEP1/2.

#### (2) Release the IDLE1/2 and SLEEP1/2 modes

IDLE1/2 and SLEEP1/2 modes include a normal release mode and an interrupt release mode. These modes are selected by interrupt master enable flag (IMF). After releasing IDLE1/2 and SLEEP1/2 modes, the SYSCR2<IDLE> is automatically cleared to "0" and the operation mode is returned to the mode preceding IDLE1/2 and SLEEP1/2 modes.

IDLE1/2 and SLEEP1/2 modes can also be released by inputting low level on the  $\overline{\text{RESET}}$  pin. After releasing reset, the operation mode is started from NORMAL1 mode.

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(3) Normal release mode (IMF = “0”)

IDLE1/2 and SLEEP1/2 modes are released by any interrupt source enabled by the individual interrupt enable flag (EF). After the interrupt is generated, the program operation is resumed from the instruction following the IDLE1/2 and SLEEP1/2 modes start instruction. Normally, the interrupt latches (IL) of the interrupt source used for releasing must be cleared to “0” by load instructions.

(4) Interrupt release mode (IMF = “1”)

IDLE1/2 and SLEEP1/2 modes are released by any interrupt source enabled with the individual interrupt enable flag (EF) and the interrupt processing is started. After the interrupt is processed, the program operation is resumed from the instruction following the instruction, which starts IDLE1/2 and SLEEP1/2 modes.

Note: When a watchdog timer interrupts is generated immediately before IDLE1/2 and SLEEP1/2 mode are started, the watchdog timer interrupt will be processed but IDLE1/2 and SLEEP1/2 mode will not be started.

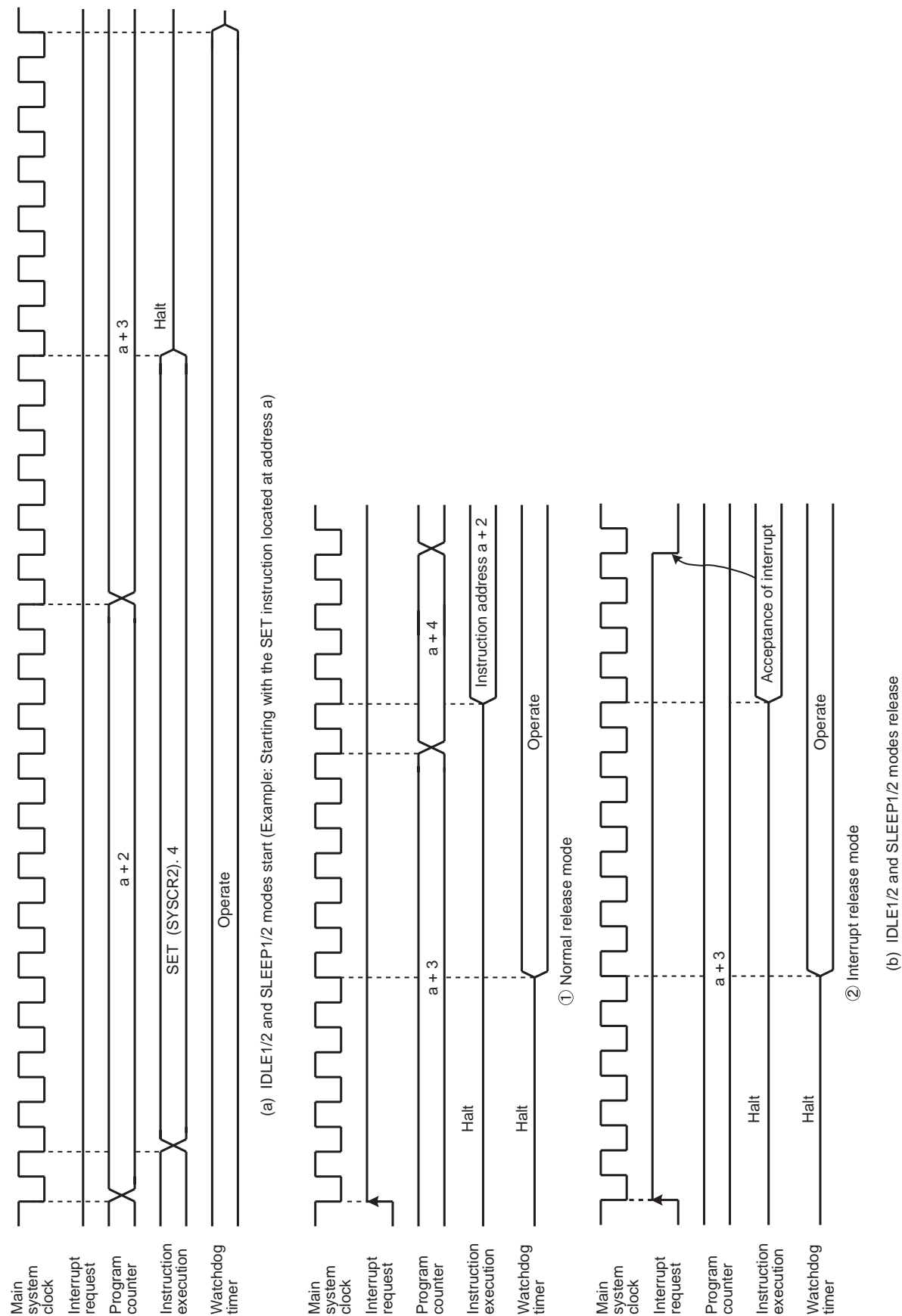


Figure 2-11 IDLE1/2 and SLEEP1/2 Modes Start/Release

### 2.2.4.3 IDLE0 and SLEEP0 modes (IDLE0, SLEEP0)

IDLE0 and SLEEP0 modes are controlled by the system control register 2 (SYSCR2) and the time base timer control register (TBTCCR). The following status is maintained during IDLE0 and SLEEP0 modes.

1. Timing generator stops feeding clock to peripherals except TBT.
2. The data memory, CPU registers, program status word and port output latches are all held in the status in effect before IDLE0 and SLEEP0 modes were entered.
3. The program counter holds the address 2 ahead of the instruction which starts IDLE0 and SLEEP0 modes.

Note: Before starting IDLE0 or SLEEP0 mode, be sure to stop (Disable) peripherals.

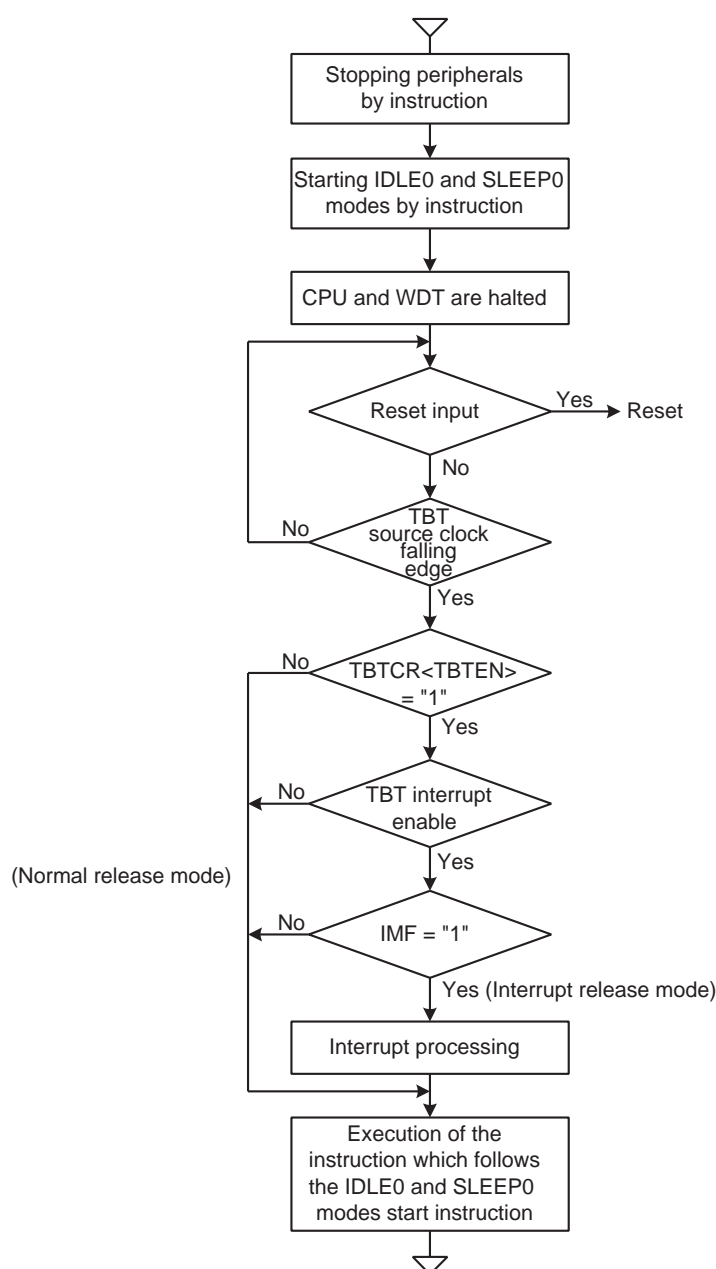


Figure 2-12 IDLE0 and SLEEP0 Modes

- (1) Start the IDLE0 and SLEEP0 modes

Stop (Disable) peripherals such as a timer counter.

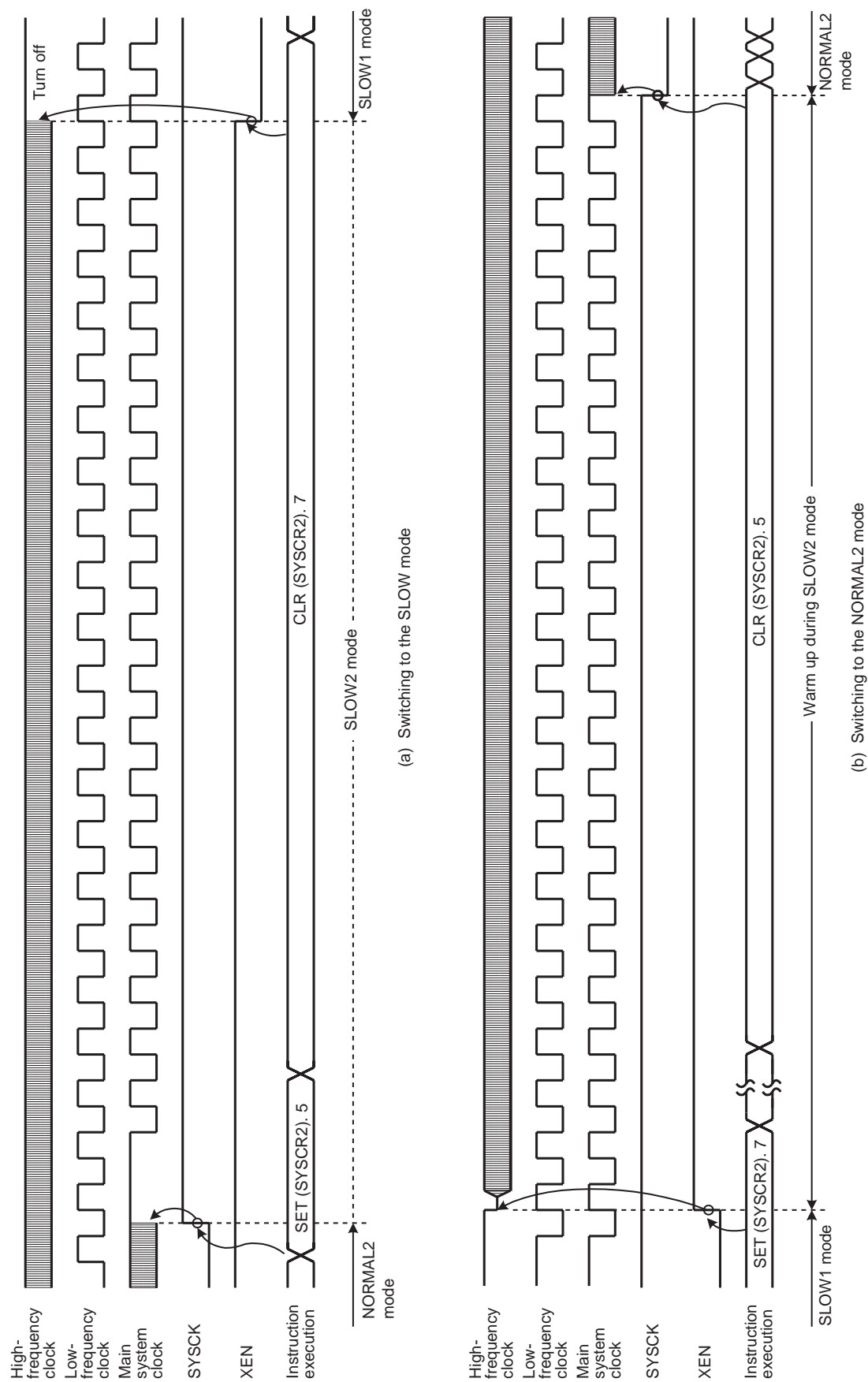


Figure 2-14 Switching between the NORMAL2 and SLOW Modes

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## 22.2 Recommended Operating Conditions

The recommended operating conditions for a device are operating conditions under which it can be guaranteed that the device will operate as specified. If the device is used under operating conditions other than the recommended operating conditions (supply voltage, operating temperature range, specified AC/DC values etc.), malfunction may occur. Thus, when designing products which include this device, ensure that the recommended operating conditions for the device are always adhered to.

### 22.2.1 MCU mode (Flash Programming or erasing)

( $V_{SS} = 0\text{ V}$ ,  $T_{opr} = -10\text{ to }40^{\circ}\text{C}$ )

Parameter	Symbol	Pins	Ratings	Min	Max	Unit
Supply voltage	V <sub>DD</sub>		NORMAL1, 2 modes	4.5	5.5	V
Input high level	V <sub>IH1</sub>	Except hysteresis input	V <sub>DD</sub> ≥ 4.5 V	V <sub>DD</sub> × 0.70	V <sub>DD</sub>	
	V <sub>IH2</sub>	Hysteresis input		V <sub>DD</sub> × 0.75		
Input low level	V <sub>IL1</sub>	Except hysteresis input	V <sub>DD</sub> ≥ 4.5 V	0	V <sub>DD</sub> × 0.30	
	V <sub>IL2</sub>	Except hysteresis input			V <sub>DD</sub> × 0.25	
Clock frequency	fc	XIN, XOUT		1.0	16.0	MHz

### 22.2.2 MCU mode (Except Flash Programming or erasing)

( $V_{SS} = 0\text{ V}$ ,  $T_{opr} = -40\text{ to }85^{\circ}\text{C}$ )

Parameter	Symbol	Pins	Ratings		Min	Max	Unit
Supply voltage (Condition 1)	V <sub>DD</sub>		fc = 16 MHz	NORMAL1, 2 modes IDLE0, 1, 2 modes	4.5	5.5	V
			fs = 32.768 KHz	SLOW1, 2 modes SLEEP0, 1, 2 modes			
			STOP mode				
Supply voltage (Condition 2)			fc = 8 MHz	NORMAL1, 2 modes IDLE0, 1, 2 modes	3.0	3.6	
			fs = 32.768 KHz	SLOW1, 2 modes SLEEP0, 1, 2 modes			
			STOP mode				
Input high level		V <sub>IH1</sub>	Except hysteresis input	V <sub>DD</sub> ≥ 4.5 V	V <sub>DD</sub> × 0.70	V <sub>DD</sub>	
		V <sub>IH2</sub>	Hysteresis input		V <sub>DD</sub> × 0.75		
		V <sub>IH3</sub>			V <sub>DD</sub> < 4.5 V		
Input low level		V <sub>IL1</sub>	Except hysteresis input	V <sub>DD</sub> ≥ 4.5 V	0	V <sub>DD</sub> × 0.30	
	V <sub>IL2</sub>	Hysteresis input	V <sub>DD</sub> × 0.25				
	V <sub>IL3</sub>		V <sub>DD</sub> < 4.5 V			V <sub>DD</sub> × 0.10	
Clock frequency	fc	XIN, XOUT	V <sub>DD</sub> = 3.0 to 3.6 V, 4.5 to 5.5V		1.0	8.0	MHz
	fc	XIN, XOUT	V <sub>DD</sub> = 4.5 to 5.5 V		1.0	16.0	
	fs	XTIN, XTOUT	V <sub>DD</sub> = 3.0 to 3.6 V, 4.5 to 5.5V		30.0	34.0	kHz

Note 1: The Supply voltage ( $V_{DD}$ ) is divided into two different voltage areas. Do not change  $V_{DD}$  from Condition 1 to Condition 2 and vice versa while the MCU is operating. If you wish to use  $V_{DD}$  in a continuous range of 3.0V to 5.5V without stopping the MCU, please contact your local Toshiba office.

## 22.2.3 Serial PROM mode

(V<sub>SS</sub> = 0 V, T<sub>opr</sub> = -10 to 40 °C)

Parameter	Symbol	Pins	Condition	Min	Max	Unit
Supply voltage	V <sub>DD</sub>		NORMAL 1, 2 modes	4.5	5.5	V
Input high voltage	V <sub>IH1</sub>	Except hysteresis input	V <sub>DD</sub> ≥ 4.5 V	V <sub>DD</sub> × 0.70	V <sub>DD</sub>	
	V <sub>IH2</sub>	Hysteresis input		V <sub>DD</sub> × 0.75		
Input low voltage	V <sub>IL1</sub>	Except hysteresis input	V <sub>DD</sub> ≥ 4.5 V	0	V <sub>DD</sub> × 0.30	
	V <sub>IL2</sub>	Hysteresis input			V <sub>DD</sub> × 0.25	
Clock frequency	fc	XIN, XOUT		2.0	16.0	MHz

## 22.4 AD Characteristics

(V<sub>SS</sub> = 0.0 V, 4.5 V ≤ V<sub>DD</sub> ≤ 5.5 V, Topr = -40 to 85 °C)

Paramete	Symbol	Condition	Min	Typ.	Max	Unit
Analog reference voltage	V <sub>AREF</sub>		A <sub>VDD</sub> - 1.0	–	A <sub>VDD</sub>	V
Power supply voltage of analog control circuit	A <sub>VDD</sub>		V <sub>DD</sub>			
Analog reference voltage range (Note 4)	Δ V <sub>AREF</sub>		3.5	–	–	
Analog input voltage	V <sub>AIN</sub>		V <sub>SS</sub>	–	V <sub>AREF</sub>	
Power supply current of analog reference voltage	I <sub>REF</sub>	V <sub>DD</sub> = A <sub>VDD</sub> = V <sub>AREF</sub> = 5.5 V V <sub>SS</sub> = A <sub>VSS</sub> = 0.0 V	–	0.6	1.0	mA
Non linearity error		V <sub>DD</sub> = A <sub>VDD</sub> = 5.0 V, V <sub>SS</sub> = A <sub>VSS</sub> = 0.0 V V <sub>AREF</sub> = 5.0 V	–	–	±2	LSB
Zero point error			–	–	±2	
Full scale error			–	–	±2	
Total error			–	–	±2	

(V<sub>SS</sub> = 0 V, 3.0 V ≤ V<sub>DD</sub> ≤ 3.6 V, Topr = -40 to 85°C)

Parameter	Symbol	Condition	Min	Typ.	Max	Unit
Analog reference voltage	V <sub>AREF</sub>		A <sub>VDD</sub> - 1.0	–	A <sub>VDD</sub>	V
Power supply voltage of analog control circuit	A <sub>VDD</sub>		V <sub>DD</sub>			
Analog reference voltage range (Note 4)	Δ V <sub>AREF</sub>		2.5	–	–	
Analog input voltage	V <sub>AIN</sub>		V <sub>SS</sub>	–	V <sub>AREF</sub>	
Power supply current of analog reference voltage	I <sub>REF</sub>	V <sub>DD</sub> = A <sub>VDD</sub> = V <sub>AREF</sub> =3.6 V V <sub>SS</sub> = A <sub>VSS</sub> = 0.0 V	–	0.5	0.8	mA
Non linearity error		V <sub>DD</sub> = A <sub>VDD</sub> = 3.0 V V <sub>SS</sub> = A <sub>VSS</sub> = 0.0 V V <sub>AREF</sub> = 3.0 V	–	–	±2	LSB
Zero point error			–	–	±2	
Full scale error			–	–	±2	
Total error			–	–	±2	

Note 1: The total error includes all errors except a quantization error, and is defined as a maximum deviation from the ideal conversion line.

Note 2: Conversion time is different in recommended value by power supply voltage.

Note 3: The voltage to be input on the AIN input pin must not exceed the range between V<sub>AREF</sub> and V<sub>SS</sub>. If a voltage outside this range is input, conversion values will become unstable and conversion values of other channels will also be affected.

Note 4: Analog reference voltage range: ΔV<sub>AREF</sub> = V<sub>AREF</sub> - V<sub>SS</sub>

Note 5: When AD converter is not used, fix the AVDD and VAREF pin on the V<sub>DD</sub> level.

## 22.5 AC Characteristics

(V<sub>SS</sub> = 0 V, V<sub>DD</sub> = 4.5 V to 5.5 V, Topr = -40 to 85°C)

Parameter	Symbol	Condition	Min	Typ.	Max	Unit
Machine cycle time	tcy	NORMAL1, 2 modes	0.25	–	4	μs
		IDLE0, 1, 2 modes				
		SLOW1, 2 modes	117.6	–	133.3	
		SLEEP0, 1, 2 modes				
High-level clock pulse width	t <sub>WCH</sub>	For external clock operation (XIN input) fc = 16 MHz	–	31.25	–	ns
Low-level clock pulse width	t <sub>WCL</sub>					
High-level clock pulse width	t <sub>WSH</sub>	For external clock operation (XTIN input) fs = 32.768 kHz	–	15.26	–	μs
Low-level clock pulse width	t <sub>WSL</sub>					

(V<sub>SS</sub> = 0 V, V<sub>DD</sub> = 3.0 V to 3.6 V, Topr = -40 to 85°C)

Paramete	Symbol	Condition	Min	Typ.	Max	Unit
Machine cycle time	t <sub>cy</sub>	NORMAL1, 2 modes	0.5	–	4	μs
		IDLE0, 1, 2 modes				
		SLOW1, 2 modes	117.6	–	133.3	
		SLEEP0, 1, 2 modes				
High-level clock pulse width	t <sub>WCH</sub>	For external clock operation (XIN input) fc = 8 MHz	–	62.5	–	ns
Low-level clock pulse width	t <sub>WCL</sub>					
High-level clock pulse width	t <sub>WSH</sub>	For external clock operation (XTIN input) fs = 32.768 kHz	–	15.26	–	μs
Low-level clock pulse width	t <sub>WSL</sub>					

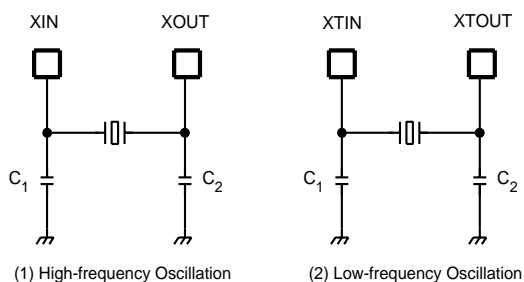
## 22.6 Flash Characteristics

### 22.6.1 Write/Retention Characteristics

(V<sub>SS</sub> = 0 V)

Parameter	Condition	Min	Typ.	Max.	Unit
Number of guaranteed writes to flash memory	V <sub>SS</sub> = 0 V, Topr = -10 to 40°C	–	–	100	Times

## 22.7 Recommended Oscillating Conditions



Note 1: To ensure stable oscillation, the resonator position, load capacitance, etc. must be appropriate. Because these factors are greatly affected by board patterns, please be sure to evaluate operation on the board on which the device will actually be mounted.

Note 2: The product numbers and specifications of the resonators by Murata Manufacturing Co., Ltd. are subject to change. For up-to-date information, please refer to the following URL:  
<http://www.murata.co.jp/search/index.html>

## 22.8 Handling Precaution

- The solderability test conditions for lead-free products (indicated by the suffix G in product name) are shown below.

1. When using the Sn-63Pb solder bath
  - Solder bath temperature = 230 °C
  - Dipping time = 5 seconds
  - Number of times = once
  - R-type flux used
2. When using the Sn-3.0Ag-0.5Cu solder bath
  - Solder bath temperature = 245 °C
  - Dipping time = 5 seconds
  - Number of times = once
  - R-type flux used

Note: The pass criterion of the above test is as follows:

Solderability rate until forming  $\geq 95\%$

- When using the device (oscillator) in places exposed to high electric fields such as cathode-ray tubes, we recommend electrically shielding the package in order to maintain normal operating condition.